

COE 545, Term 022

Digital System Testing

HW#2

Due date: Sunday, April 6

- Q.1.** For the circuit shown in Figure 5.38, determine the faults detected by each of the test vectors 101 and 010 based on each of the following methods, starting with a collapsed fault set based on fault equivalence. Show the details of each method.
- (i) Deductive fault simulation.
 - (ii) Critical path tracing.
 - (iii) Verify your answer using the CPT implementation given in class using the following command: `hope -t circuit.hope -C circuit.log -L 7 circuit.bench`. Note that `circuit.hope` is the file containing the test vectors, `circuit.log` is the file that will contain the results, and `circuit.bench` is the file containing the circuit.
- Q.2.** Consider the full-scanned version of the circuit `s5378f` given as `s5378f.bench`. The number of collapsed faults in this circuit is 4603. The test set `s5378f.vec` detects 4563 faults, i.e. producing a fault coverage equal to 99.13%. Note that the remaining faults are redundant.
- (i) Perform fault simulation of the test set on a randomly selected sample of m faults for each of the following values of m : 50, 100, 500, and 1000. Determine the fault coverage obtained, compare it to the exact fault coverage, and determine the error in each case.
 - (ii) Reverse the order of the test vectors in `s5378f.vec`. Then, fault simulate the reversed test set on all the faults and remove the vectors that no longer detect any fault. Comment on why this procedure can reduce the test set.
- Q.3.** Consider the circuits shown in Figure 5.38. Assume that the faults to be simulated are $d s-1$, $e s-a-0$, and $b s-a-1$. Determine the expected number of detected faults and the detection probability for each fault for the test sequence $T(a, b, c) = \{011, 000, 111, 101\}$. Perform fault simulation of the test set T and determine which of these faults are detected. Then, correlate the detection probability of each fault with its actual detectability status.